



# **CE EMC Test Report**

Project No. : 1907C057

Equipment Test Model : Gaming Mouse Mat

: RZ02-0302

Series Model : RZ02-0302XXXX-XXXX (X: Can Be :A~Z, 0~9)

**Applicant**: Razer Inc.

Address : 201 3rd Street, Suite 900, San Francisco, CA 94103

USA

Date of Receipt: Jul. 05, 2019

**Date of Test** : Jul. 11, 2019 ~ Jul. 19, 2019

**Issued Date** : Oct. 08, 2019 **Tested by : BTL Inc.** 

**Testing Engineer** 

**Technical Manager** 

(Bill Zhang)

**Authorized Signatory** 

# BTL INC

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Certificate #5123.02

Report No.: BTL-EMC-1-1907C057 Page 1 of 56 Report Version: R00





#### **Declaration**

BTL represents to the client that testing is done in accordance with standard procedures as applicable and that test instruments used has been calibrated with standards traceable to international standard(s) and/or national standard(s).

BTL's reports apply only to the specific samples tested under conditions. It is manufacture's responsibility to ensure that additional production units of this model are manufactured with the identical electrical and mechanical components. BTL shall have no liability for any declarations, inferences or generalizations drawn by the client or others from BTL issued reports.

The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP. NIST, A2LA, or any agency of the U.S. Government.

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BTL's laboratory quality assurance procedures are in compliance with the ISO/IEC 17025 requirements, and accredited by the conformity assessment authorities listed in this test report.

BTL is not responsible for the sampling stage, so the results only apply to the sample as received.

The information, data and test plan are provided by manufacturer which may affect the validity of results, so it is manufacturer's responsibility to ensure that the apparatus meets the essential requirements of applied standards and in all the possible configurations as representative of its intended use.

#### Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective. Please note that the measurement uncertainty is provided for informational purpose only and are not use in determining the Pass/Fail results.

Report No.: BTL-EMC-1-1907C057





Table of Contents	Page
REPORT ISSUED HISTORY	6
1. GENERAL SUMMARY	7
2 . SUMMARY OF TEST RESULTS	8
2.1 TEST FACILITY	10
2.2 MEASUREMENT UNCERTAINTY	10
3 . GENERAL INFORMATION	12
3.1 GENERAL DESCRIPTION OF EUT	12
3.2 DESCRIPTION OF TEST MODES	12
3.3 EUT OPERATING CONDITIONS	13
3.4 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED	
3.5 DESCRIPTION OF SUPPORT UNITS	14
4 .EMC EMISSION TEST	15
4.1 RADIATED EMISSION 4.1.1 LIMITS	15 15
4.1.2 MEASUREMENT INSTRUMENTS LIST	16
4.1.3 TEST PROCEDURE 4.1.4 DEVIATIONFROMTESTSTANDARD	17 17
4.1.5 TESTSETUP	17
4.1.6 MEASUREMENT DISTANCE	18
4.1.7 TEST RESULTS (UP TO 1 GHZ) 4.2 CONDUCTED EMISSION MEASUREMENTAT AC MAINS POWER PORTS	19 21
4.2.1 LIMITS	21
4.2.2 MEASUREMENT INSTRUMENTS LIST	21
4.2.3 TEST PROCEDURE 4.2.4 DEVIATION FROM TEST STANDARD	22 22
4.2.5 TEST SETUP	22
4.2.6 TEST RESULTS	23
5 . EMC IMMUNITY TEST	25
5.1 STANDARD COMPLIANCE/SEVERITY LEVEL/CRITERIA	25
5.2 GENERAL PERFORMANCE CRITERIA	28
5.3 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD) 5.3.1 TEST SPECIFICATION	29 29
5.3.2 MEASUREMENT INSTRUMENTS	29
5.3.3 TEST PROCEDURE 5.3.4 DEVIATION FROM TEST STANDARD	29 30
5.3.5 TEST SETUP	30 30
5.3.6 TEST RESULTS	31





Table of Contents	Page
5.4 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY	•
TEST (RS)	33
5.4.1 TEST SPECIFICATION	33
5.4.2 MEASUREMENT INSTRUMENTS	33
5.4.3 TEST PROCEDURE	33
5.4.4 DEVIATION FROM TEST STANDARD	33
5.4.5 TEST SETUP	34
5.4.6 TEST RESULTS	35
5.5 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT/BURST)	36
5.5.1 TEST SPECIFICATION	36
5.5.2 MEASUREMENT INSTRUMENTS	36
5.5.3 TEST PROCEDURE	36
5.5.4 DEVIATION FROM TEST STANDARD	36
5.5.5 TEST SETUP	37
5.5.6 TEST RESULTS	38
5.6 SURGE IMMUNITY TEST	39
5.6.1 TEST SPECIFICATION	39
5.6.2 MEASUREMENT INSTRUMENTS	39
5.6.3 TEST PROCEDURE	40
5.6.4 DEVIATION FROM TEST STANDARD	40
5.6.5 TEST SETUP	40
5.6.6 TEST RESULTS	41
5.7 IMMUNITY TO CONDUCTED DISTURBANCES, INDUCED BY	
RADIO-FREQUENCY FIELDS TEST (CS)	42
5.7.1 TEST SPECIFICATION	42
5.7.2 MEASUREMENT INSTRUMENTS	42
5.7.3 TEST PROCEDURE	42
5.7.4 DEVIATION FROM TEST STANDARD	43
5.7.5 TEST SETUP 5.7.6 TEST RESULTS	43 44
5.8 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST (PFMF) 5.8.1 TEST SPECIFICATION	45 45
5.8.2 MEASUREMENT INSTRUMENTS	45 45
5.8.3 TEST PROCEDURE	45 45
5.8.4 DEVIATION FROM TEST STANDARD	45
5.8.5 TEST SETUP	46
5.8.6 TEST RESULTS	47
5.9 VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS	
IMMUNITY TEST	48
5.9.1 TEST SPECIFICATION	48
5.9.2 MEASUREMENT INSTRUMENTS	48
5.9.3 TEST PROCEDURE	48

Report No.: BTL-EMC-1-1907C057

Page 4 of 56 Report Version: R00





Table of Contents	Page
5.9.4 DEVIATION FROM TEST STANDARD	48
5.9.5 TEST SETUP	49
5.9.6 TEST RESULTS	50
6 EUT TEST DUOTO	51

Report No.: BTL-EMC-1-1907C057

Page 5 of 56 Report Version: R00





### **REPORT ISSUED HISTORY**

Report Version	Description	Issued Date
R00	Original Issue.	Oct. 08, 2019

Report No.: BTL-EMC-1-1907C057 Page 6 c





### 1. GENERAL SUMMARY

Equipment : Gaming Mouse Mat

Brand Name: RAZER
Test Model: RZ02-0302

Series Model: RZ02-0302XXXX-XXXX (X: Can Be :A~Z, 0~9)

Applicant : Razer Inc.

Manufacturer: Razer (Asia-Pacific) Pte.,Ltd.

Address : 514 Chai Chee Lane, #07-01-06, Singapore 469029

Factory : RAZER TECHNOLOGY AND DEVELOPMENT (SHENZHEN) CO., LTD

Address : East Wing, 3rd Floor, Block 2, Phase 1 of Vision Shenzhen Business Park Keji

South Road, Hi-Tech Industrial Park, Shenzhen 518057, China

Date of Test : Jul. 11, 2019 ~ Jul. 19, 2019

Test Sample: Engineering Sample No.: DG19070252 Standard(s): EN 55032:2015+AC:2016 Class B

> EN 55035:2017 EN 61000-4-2:2009

EN 61000-4-3:2006+A1:2008+A2:2010

EN 61000-4-4:2012 EN 61000-4-5:2014 EN 61000-4-6:2014 EN 61000-4-8:2010 EN 61000-4-11:2004

The above equipment has been tested and found compliance with the requirement of the relative standards by BTL Inc.

The test data, data evaluation, and equipment configuration contained in our test report (Ref No. BTL-EMC-1-1907C057) were obtained utilizing the test procedures, test instruments, test sites that has been accredited by the Authority of A2LA according to the ISO/IEC 17025 quality assessment standard and technical standard(s).

Report No.: BTL-EMC-1-1907C057





### 2. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

Emission					
Standard(s)	Test	Item	Limit	Judgment	Remark
	Radiated e		Class B	PASS	
	Radiated emissions above 1 GHz			N/A	NOTE (1) NOTE (2)
	Radiated emissions from FM receivers			N/A	NOTE (1) NOTE (6)
EN 55032: 2015+AC:2016	Conducted AC mains p		Class B	PASS	NOTE (7)
2013170.2010	Asymmetric	AAN		N/A	
	mode conducted	Current Probe		N/A	NOTE (1) NOTE (8)
	emissions	CVP		N/A	
	Conducted differential voltage emissions			N/A	NOTE (1) NOTE (9)

Immunity (EN 55035:2017)				
Section(s)	Test Item	Performance Criterion	Results Judgment	Remark
EN 61000-4-2:2009	Electrostatic discharge immunity	В	PASS	
EN 61000-4-3:2006+A1:200 8+A2:2010	Continuous RF electromagne tic field disturbances	А	PASS	
EN 61000-4-4:2012	Electrical fast transient/burst immunity	В	PASS	
EN 61000-4-5:2014	Surge immunity	B/C	PASS	NOTE (4)
EN 61000-4-6:2014	Continuous induced RF disturbances	А	PASS	
EN 61000-4-8:2010	Power frequency magnetic field immunity	А	PASS	
EN 61000-4-11:2004	Voltage dips, short interruptions and voltage variations immunity	B/C/C	PASS	NOTE (5)
4.2.7	4.2.7 Broadbandimpulse noisedisturbances,repetitive		N/A	NOTE (1)
4.2.7	4.2.7 Broadbandimpulse noisedisturbances,isolated		N/A	NOTE (1)

Report No.: BTL-EMC-1-1907C057

Page 8 of 56 Report Version: R00





### NOTE:

- (1) "N/A" denotes test is not applicable to this device.
- (2) The EUT's max operating frequency is 48 MHz which does not exceed 108 MHz, so the test will not be performed.
- (3) If the power consumption is less than 75W, there is no limit applied.
- (4) Port Type: unshielded symmetrical:

Performance Criterion C for signal ports and telecommunication ports.

Port Type: coaxial or shielded:

Performance Criterion B for signal ports and telecommunication ports.

Performance Criterion B for input d.c. power port and a.c. power ports.

- (5) Voltage dips:
  - (B) Residual voltage < 5% 0.5 Cycles
  - (C) Residual voltage70% 25 Cycles (50Hz),30 Cycles (60Hz)

Voltage interruptions:

- (C) Residual voltage < 5% 250 Cycles (50Hz),300 Cycles (60Hz)
- (6) If the EUT has FM function the test will be performed.
- (7) If the EUT has AC power mains port the test will be performed.

(8)

Cable Type	Number of pairs	Measurement type	Procedures
Balanced Unscreened	1 (2 wire);2 (4 wire); 3 (6 wire);4 (8 wire)	Voltage	AAN
Balanced Unscreened	See a)	Voltage and Current	CP+CVP
Screened or Coaxial	n/a	Voltage	AAN
Screened or Coaxial	n/a	Voltage or Current	CP or CVP
Unbalanced cables	n/a	Voltage and Current	CP+CVP

Ports connected to cables with more than 4 balanced pairs or where the port is unable to function correctly whenconnected through an AAN.

- (9) If the EUT has tuner port the test will be performed.
- (10) The requirement followed by the client's specification.

Report No.: BTL-EMC-1-1907C057

Page 9 of 56 Report Version: R00





### 2.1 TEST FACILITY

The test facilities used to collect the test data in this report is at the location of No.3, Jinshagang 1st Road, Shixia, Dalang Town, Dongguan, Guangdong, China.

### 2.2 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2, The BTL measurement uncertainty is less than the CISPR 16-4-2 U<sub>cispr</sub> requirement.

The reported uncertainty of measurement y ±U, where expanded uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95%.

A. Radiated emissions up to 1 GHzmeasurement:

Test Site	Method	Measurement Frequency Range	Ant. H / V	U, (dB)
DG-CB08 (10m) CISPR		30MHz ~ 200MHz	V	4.54
	CIEDD	30MHz ~ 200MHz	Н	3.98
	CISPR	200MHz ~ 1,000MHz	V	3.98
		200MHz ~ 1,000MHz	Н	3.76

B. Conducted emissions AC mains power port measurement:

	Test Site	Method	Measurement Frequency Range	U, (dB)
Ī	DG-C02	CISPR	150 kHz ~ 30MHz	2.32

Report No.: BTL-EMC-1-1907C057 Page 10 of 56





C. Immunity Measurement:

. Inmunity Measurement.					
Test Site	Method	Measurement Frequency Range	U, (dB)		
		Rise time tr	14.60 %		
DG-SR02	EN 61000-4-2	Peak current lp	1.72 %		
DO-31102		Current at 30 ns	2.0 %		
		Current at 60 ns	1.84 %		
		80 MHz~1 GHz, 1 GHz~6 GHz	2.175 dB		
		On-ear acoustic & Acoustic measurements	2.287 dB		
		on loudspeakers	2.207 UD		
		Electrical measurements	2.267 dB		
DG-CB05	EN 61000-4-3	Measuring the demodulation on analogue	2.267 dB		
DO-000	LIN 0 1000-4-3	wired network lines	2.207 UD		
		Audio breakthrough measurement, test	2.349 dB		
		set-up for RS 2G/3G	2.549 UD		
		Audio breakthrough measurement, test	2.413 dB		
		set-up for RS 4G			
		Voltage rise time (tr)	10.40 %		
DG-SR05 EN 610	EN 61000-4-4	Voltage peak value(V <sub>P</sub> )	8.20 %		
		Voltage pulse width(tw)	6.0 %		
		Voltage front time (T <sub>fv</sub> )	5.80 %		
DG-SR05	EN 61000-4-5	Voltage peak value(V <sub>P</sub> )	3.90 %		
		Voltage duration(t <sub>d</sub> )	0.60 %		
		CDN	3.25 dB		
		EM clamp	4.410 dB		
		On-ear acoustic & Acoustic measurements	3.272 dB		
DG-CB06	EN 61000-4-6	on loudspeakers	3.272 UB		
		Electrical measurements	3.258 dB		
		measuring the demodulation on analogue	3.258 dB		
		wired network lines	3.230 UD		
DG-SR05	EN 61000-4-8	Magnetic Field Level	3.787 %		
DG-SR05	EN 61000-4-11	voltage fall time (T <sub>f</sub> )	2.0 %		

Note: Unless specifically mentioned, the uncertainty of measurement has not been taken into account to declare the compliance or non-compliance to the specification.

Report No.: BTL-EMC-1-1907C057

Page 11 of 56 Report Version: R00





### 3. GENERAL INFORMATION

### 3.1 GENERAL DESCRIPTION OF EUT

Equipment	Gaming Mouse Mat
Brand Name	RAZER
Test Model	RZ02-0302
Series Model	RZ02-0302XXXX-XXXX (X: Can Be :A~Z, 0~9)
Model Difference(s)	It is the same as the basic model and X is used to define which country it is for under the same family series.
Power Source	Supplied from USB port.
Power Rating	DC 5V 500mA
Connecting I/O Port(s)	1* USB port

#### Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the user's manual.

#### 3.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	USB LINK(Normal light)
Mode 2	USB LINK(white light)

For Radiated Test					
Final Test Mode	Final Test Mode Description				
Mode 1 USB LINK(Normal light)					

For Conducted Test					
Final Test Mode Description					
Mode 1 USB LINK(Normal light)					

For EMS Test						
Final Test Mode Description						
Mode 1	Mode 1 USB LINK(Normal light)					

Note: The worst case is recorded in this report.

Report No.: BTL-EMC-1-1907C057 Report Version: R00



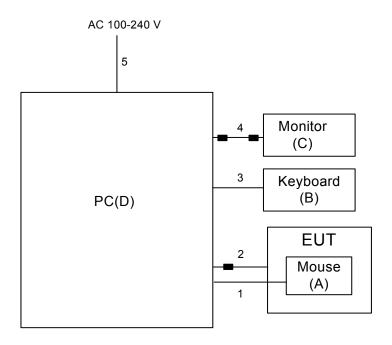


### 3.3 EUT OPERATING CONDITIONS

The EUT exercise program used during radiated and/or conducted emission measurement was designed to exercise the various system components in a manner similar to a typical use. The standard test signals and output signal as following:

- 1. EUT connected to PC via USB cable.
- 2. PC connected to monitor via D-SUB cable.
- 3. PC connected to keyboard and mouse via USB cable.

### 3.4 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED



Ferrite core

Ground plane

Remote System

Report No.: BTL-EMC-1-1907C057

Page 13 of 56 Report Version: R00





### 3.5 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	Series No.
Α	Mouse	Gaming Mouse	RZ03-0252	N/A
В	Keyboard	Gaming Keyboard	RZ01-0256	N/A
С	Monitor	DELL	E177FPC	CN-OFJ79-64180-763-0TKS
D	PC	DELL	Vostro 470	24454162837

Item	Cable Type	Shielded Type	Ferrite Core	Length
1	USB Cable	YES	NO	1.8m
2	USB Cable	YES	YES	1.8m
3	USB Cable	YES	NO	1.8m
4	D-SUB Cable	YES	YES	1.8m
5	AC Cable	NO	NO	1.8m

Report No.: BTL-EMC-1-1907C057 Page 1





### **4.EMC EMISSION TEST**

#### 4.1 RADIATED EMISSION

#### **4.1.1 LIMITS**

Class A equipment up to 1000MHz

Table clause	Frequency range MHz	Facility (see Table A.1)	Class A limits dB(µV/m)		
A2.1	30-230 230-1000	OATS/SAC	10	Ougsi poek /	40 47
	30-230	OATO/OAC 2		Quasi peak / 120 kHz	50
A2.2	230-1000	OATS/SAC	3		57
	30-230	FAR	10		42 to 35
A2.3	230-1000	FAR	10	Quasi peak /	42
	30-230	FAR	3	120 kHz	52 to 45
A2.4	230-1000	FAR	3		52
Apply onl	y A2.1 or A2.2 or <i>i</i>	A2.3 or A2.4 acr	oss the entire f	requency range.	

Class B equipment up to 1000MHz

Table	Frequency		Class B limits		
MHz (see		Facility (see Table A.1)	Distance m	Detector type/ bandwidth	dB(μV/m)
A4.1	30-230 230-1000	OATS/SAC	10	Quasi peak /	30 37
A4.2	30-230 230-1000	OATS/SAC	3	120 kHz	40 47
A4.3	30-230 230-1000	FAR	10	Quasi peak /	32 to 25 32
A4.4	30-230 230-1000	FAR	3	120 kHz	42 to 35 42

Apply only table clause A4.1 or A4.2 or A4.3 or A4.4 across the entire frequency range. These requirements are not applicable to the local oscillator and harmonics frequencies of equipment covered by Table A.6.

### Notes:

- (1) The limit for radiated test was performed according to as following: EN 55032
- (2) The tighter limit applies at the band edges.
- (3) Emission level (dBuV/m)=20log Emission level (uV/m).
- (4) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Antenna Factor + Cable Loss - Amplifier Gain(if use) Margin Level = Measurement Value - Limit Value

Report No.: BTL-EMC-1-1907C057 Page 15 of 56
Report Version: R00





Required highest frequency for radiated measurement

Highest internal frequency (F <sub>x</sub> )	Highest measured frequency
MHz	MHz
F <sub>x</sub> ≤108	1000
108 <f<sub>x≤500</f<sub>	2000
500 <f<sub>x≤1000</f<sub>	5000
F <sub>x</sub> >1000	5 <sup>th</sup> up to a maximum6 GHz,

Note for FM and TV broadcast receiver,  $F_x$  is determined from the highest frequency generated or used excluding the local oscillator and tuned frequencies.

### **4.1.2 MEASUREMENT INSTRUMENTS LIST**

### Up to 1GHz:

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Receiver	Keysight	N9038A	MY54450004	Aug. 11, 2019
2	MXE EMI Receiver	Agilent	N9038A	MY53220133	Mar. 10, 2020
3	Pre-Amplifier	EMC INSTRUMENT	EMC 9135	980284	Mar. 10, 2020
4	Pre-Amplifier	EMC INSTRUMENT	EMC 9135	980283	Mar. 10, 2020
5	Trilog-Broadband Antenna	Schwarzbeck	VULB9168	946	Nov. 24, 2019
6	Trilog-Broadband Antenna	Schwarzbeck	VULB9168	947	Nov. 24, 2019
7	Cable	emci	LMR-400(5 m+11m+15 m)	N/A	Aug. 07, 2019
8	Cable	emci	LMR-400(5 m+8m+8m)	N/A	Aug. 07, 2019
9	Measurement Software	Farad	EZ-EMC Ver.BTL-2A NT-1	N/A	N/A
10	Multi-Device Controller	ETS-Lindgren	2090	N/A	N/A
11	Attenuator	EMCI	EMCI-N-6- 06	N0670	Nov. 24, 2019
12	Attenuator	EMCI	EMCI-N-6- 06	N0671	Nov. 24, 2019

Remark: "N/A" denotes no model name, no serial no. or no calibration specified.

All calibration period of equipment list is one year.

Report No.: BTL-EMC-1-1907C057

Page 16 of 56 Report Version: R00





### 4.1.3 TEST PROCEDURE

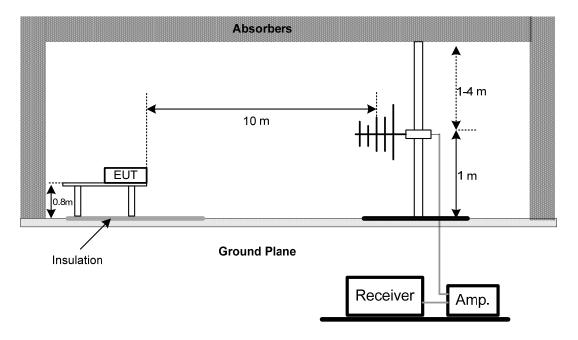
- a. The measuring distance of 10 m shall be used for measurements. The EUT was placed on the top of a rotating table 0.8 meter above the ground at a 10 meter semi-anechoic chamber. The table was rotated 360 degrees to determine the position of the highest radiation.(below 1GHz).
- b. The height of the equipment or of the substitution antenna shall be 0.8 m, the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- c. The initial step in collecting radiated emission data is a receiver peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- d. All readings are Peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform. (below 1GHz)
- e. For the actual test configuration, please refer to the related Item Block Diagram of system tested (please refer to 3.4).

### 4.1.4 DEVIATIONFROMTESTSTANDARD

No deviation

#### 4.1.5 TESTSETUP

**UP TO 1 GHZ** 



Note: The antenna can be moved between 1 to 4 meters above the ground.

Report No.: BTL-EMC-1-1907C057

Page 17 of 56 Report Version: R00





### 4.1.6 MEASUREMENT DISTANCE

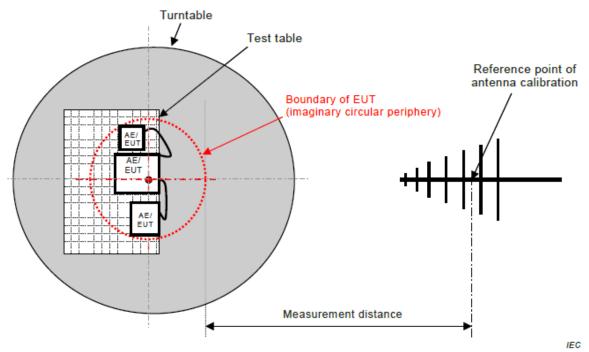


Figure C.1 - Measurement distance

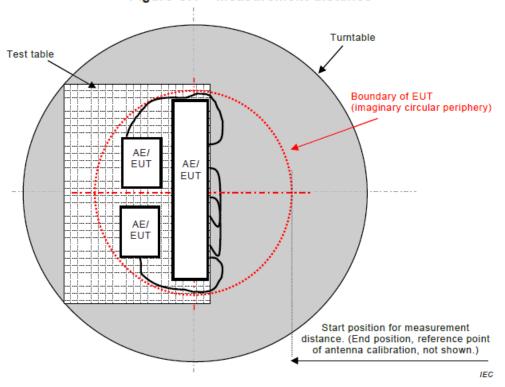


Figure C.2 - Boundary of EUT, Local AE and associated cabling

Report No.: BTL-EMC-1-1907C057

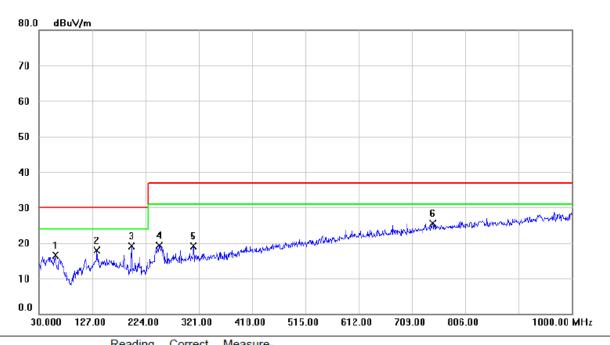
Page 18 of 56 Report Version: R00





### 4.1.7 TEST RESULTS (UP TO 1 GHZ)

EUT	Gaming Mouse Mat	Model Name	RZ02-0302
Temperature	25°C	Relative Humidity	60%
Test Voltage	AC 230V/50Hz	Polarization	Vertical
Test Mode	Mode 1		
Test Engineer	Simon Ling		



No.	Mk	. Freq.	Level	Factor	Measure- ment	Limit	Margin		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		60.0700	33.70	-17.15	16.55	30.00	-13.45	QP	
2		135.7300	34.86	-17.05	17.81	30.00	-12.19	QP	
3	*	198.7800	38.29	-19.15	19.14	30.00	-10.86	QP	
4		249.2200	36.41	-17.08	19.33	37.00	-17.67	QP	
5		311.3000	33.79	-14.71	19.08	37.00	-17.92	QP	
6		746.8300	31.92	-6.33	25.59	37.00	-11.41	QP	

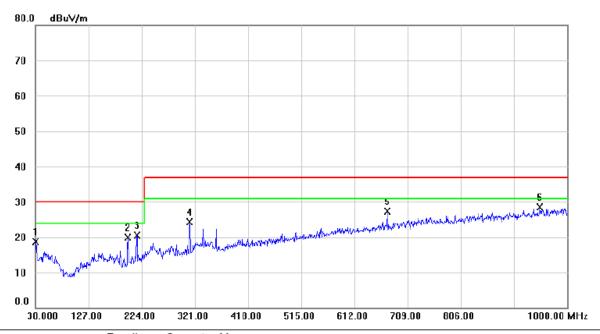
Report No.: BTL-EMC-1-1907C057

Page 19 of 56 Report Version: R00





EUT	Gaming Mouse Mat	Model Name	RZ02-0302
Temperature	25°C	Relative Humidity	60%
Test Voltage	AC 230V/50Hz	Polarization	Horizontal
Test Mode	Mode 1		
Test Engineer	Simon Ling		



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1		30.9700	36.88	-18.21	18.67	30.00	-11.33	QP	
2		198.7800	38.93	-18.94	19.99	30.00	-10.01	QP	
3		215.2700	39.73	-19.28	20.45	30.00	-9.55	QP	
4		311.3000	39.01	-14.71	24.30	37.00	-12.70	QP	
5		672.1400	34.80	-7.51	27.29	37.00	-9.71	QP	
6	*	950.5300	32.33	-3.79	28.54	37.00	-8.46	QP	

Report No.: BTL-EMC-1-1907C057

Page 20 of 56 Report Version: R00





### 4.2 CONDUCTED EMISSION MEASUREMENTAT AC MAINS POWER PORTS

### **4.2.1 LIMITS**

Requirements for conducted emissions from AC mains power ports of Class A equipment

Table clause	Frequency Range MHz	Coupling Device	Detector Type / bandwidth	Class A Limits (dB(μV))			
A9.1	0.15 - 0.5	AMN	Quasi Peak /	79			
A9.1	0.5 - 30	AIVIIN	9 kHz	73			
A9.2	0.15 - 0.5	AMN	Average /	66			
A9.2	0.5 - 30	AIVIIN	9 kHz	60			
Apply A9.1 and A9.2 across the entire frequency range.							

Requirements for conducted emissions from AC mains power ports of Class B equipment

Table clause	Frequency Range MHz	Coupling Device	Detector Type / bandwidth	Class B Limits (dB(µV))					
	0.15 - 0.5		Oversi Denk /	66-56					
A10.1	0.5 - 5	AMN	Quasi Peak / 9 kHz	56					
	5 - 30		JINIZ	60					
	0.15 - 0.5		Δ. /	56-46					
A10.2	0.5 - 5	AMN	Average / 9 kHz	46					
	5 - 30		J KIIZ	50					
Δηηίν Δ10 1 a	Apply A10.1 and A10.2 across the entire frequency range								

### NOTE:

(1) The test result calculated as following: Measurement Value = Reading Level + Correct Factor Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor(if use)

Margin Level = Measurement Value - Limit Value

### 4.2.2 MEASUREMENT INSTRUMENTS LIST

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	EMI Test Receiver	R&S	ESCI	100382	Mar. 10, 2020
2	LISN	EMCO	3816/2	52765	Mar. 10, 2020
3	TWO-LINE V-NETWORK	R&S	ENV216	101447	May. 19, 2020
4	50Ω Terminator	SHX	TF5-3	15041305	Mar. 10, 2020
5	Measurement Software	Farad	EZ-EMC Ver.NB-03A 1-01	N/A	N/A
6	Cable	N/A	RG223	12m	Mar. 12, 2020

Remark: "N/A" denotes no model name, no serial no. or no calibration specified.

All calibration period of equipment list is one year.

Report No.: BTL-EMC-1-1907C057 Page 21 of 56





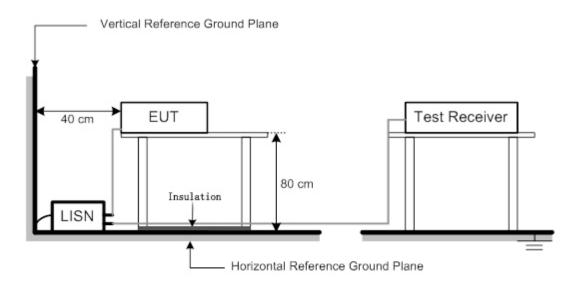
### **4.2.3 TEST PROCEDURE**

- a. The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- c. I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- d. LISN at least 80 cm from nearest part of EUT chassis.
- e. For the actual test configuration, please refer to the related Item -EUT Test Photos.

### 4.2.4 DEVIATION FROM TEST STANDARD

No deviation

### 4.2.5 TEST SETUP



Report No.: BTL-EMC-1-1907C057

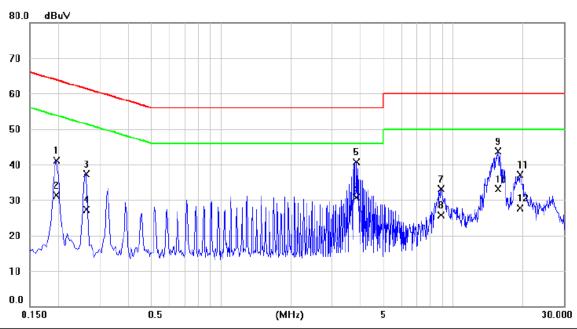
Page 22 of 56 Report Version: R00





### 4.2.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0302
Temperature	25°C	Relative Humidity	53%
Test Voltage	Test Voltage AC 230V/50Hz		Line
Test Mode	Mode 1		
Test Engineer	Simon Ling		



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
		MHz	dBu∨	dB	dBuV	dBuV	dB	Detector	Comment
1		0.1950	31.35	9.81	41.16	63.82	-22.66	QP	
2		0.1950	21.58	9.81	31.39	53.82	-22.43	AVG	
3		0.2625	27.47	9.83	37.30	61.35	-24.05	QP	
4		0.2625	17.52	9.83	27.35	51.35	-24.00	AVG	
5		3.8310	30.55	10.11	40.66	56.00	-15.34	QP	
6	*	3.8310	20.58	10.11	30.69	46.00	-15.31	AVG	
7		8.8935	22.58	10.43	33.01	60.00	-26.99	QP	
8		8.8935	15.34	10.43	25.77	50.00	-24.23	AVG	
9		15.6075	32.85	10.79	43.64	60.00	-16.36	QP	
10		15.6075	22.36	10.79	33.15	50.00	-16.85	AVG	
11		19.4100	26.04	11.14	37.18	60.00	-22.82	QP	
12		19.4100	16.57	11.14	27.71	50.00	-22.29	AVG	

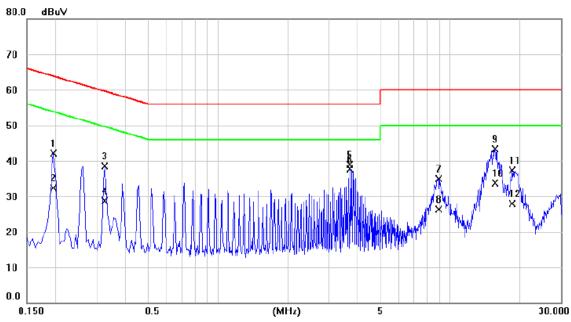
Report No.: BTL-EMC-1-1907C057

Page 23 of 56 Report Version: R00





EUT	Gaming Mouse Mat	Model Name	RZ02-0302
Temperature	25°C	Relative Humidity	53%
Test Voltage	AC 230V/50Hz	Phase	Neutral
Test Mode	Mode 1		
Test Engineer	Simon Ling		



No. MI	k. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Margin		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1	0.1950	32.11	9.90	42.01	63.82	-21.81	QP	
2	0.1950	22.46	9.90	32.36	53.82	-21.46	AVG	
3	0.3255	28.53	9.98	38.51	59.57	-21.06	QP	
4	0.3255	18.67	9.98	28.65	49.57	-20.92	AVG	
5	3.7050	28.64	10.30	38.94	56.00	-17.06	QP	
6 *	3.7050	27.47	10.30	37.77	46.00	-8.23	AVG	
7	8.9070	24.30	10.68	34.98	60.00	-25.02	QP	
8	8.9070	15.67	10.68	26.35	50.00	-23.65	AVG	
9	15.6255	32.25	11.13	43.38	60.00	-16.62	QP	
10	15.6255	22.59	11.13	33.72	50.00	-16.28	AVG	
11	18.5550	25.93	11.37	37.30	60.00	-22.70	QP	
12	18.5550	16.57	11.37	27.94	50.00	-22.06	AVG	

Report No.: BTL-EMC-1-1907C057

Page 24 of 56 Report Version: R00





### **5. EMC IMMUNITY TEST**

### 5.1 STANDARD COMPLIANCE/SEVERITY LEVEL/CRITERIA

Tests Standard No.	Test Specification Level / Test Mode	Test Ports	Criteria
Electrostatic discharge EN 61000-4-2	±8kV air discharge ±4kV contact discharge (Direct Mode)	Enclosure	В
(ESD)	±4kV HCP discharge ±4kV VCP discharge (Indirect Mode)	Enclosure	В
Continuous RF electromagne tic field disturbances,swept test EN 61000-4-3 (RS)	80 MHz to 1000 MHz 3V/m(unmodulated, r.m.s), 1 kHz, 80%, AM modulated	Enclosure	A
Continuous RF electromagne tic field disturbances,spot test EN 61000-4-3 (RS)	1800 MHz, 2600MHz, 3500 MHz, 5000MHz(±1 %) 3V/m(unmodulated, r.m.s), 1 kHz, 80%, AM modulated	Enclosure	А
Electrical fast transient/burst	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency (100kHz Repetition Frequency for xDSL port)	Analogue/digital data ports (NOTE 1)	В
immunity EN 61000-4-4 (EFT/Burst)	±0.5kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	DC network power ports (NOTE 1)	В
	±1 kV(peak) 5/50ns Tr/Th 5kHz Repetition Frequency	AC mains power ports	В

Report No.: BTL-EMC-1-1907C057





	Port Type: unshielded symmetrical Apply: lines to ground						
	Primary protection is Intended ±1 kV and ±4 kV 10/700(5/320)Tr/Th µs(NOTE 3)	Analogue/digital data	С				
	Primary protection is not Intended ±1 kV 10/700(5/320) Tr/Th µs(NOTE 3)	ports (NOTE 1)	С				
	Port type: coaxial or shielded  Apply: shield to ground						
Surge immunity EN 61000-4-5 Surges)	±0.5 kV 1.2/50(8/20) Tr/Th μs( <b>NOTE 3</b> )	Analogue/digital data ports (NOTE 1)	В				
	line to reference ground for each individual line: ±0.5 kV(peak) 1.2/50(8/20) Tr/Th µs	DC network power ports (NOTE 1)& (NOTE 2)	В				
	±1 kV(peak) 1.2/50(8/20) Tr/Th μs (line to line) ±2 kV(peak) 1.2/50(8/20) Tr/Th μs (line to earth or ground)	AC mains power ports	В				
	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	Analogue/digital data ports (NOTE 1)	Α				
Continuous induced RF isturbances IN 61000-4-6 njected Current)	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	DC network power ports (NOTE 1)	A				
	0.15 MHz to 10 MHz 3V(unmodulated, r.m.s), 10 MHz to 30 MHz 3V to 1V(unmodulated, r.m.s), 30 MHz to 80 MHz 1V(unmodulated, r.m.s), 1kHz 80%, AM 150Ω source impedance	AC mains power ports	Α				

Report No.: BTL-EMC-1-1907C057

Page 26 of 56 Report Version: R00





Power frequency magnetic field immunity EN 61000-4-8 (PFMF)	50 Hz or 60Hz, 1A/m(r.m.s)	Enclosure	Α
Voltage dips, short interruptions and voltage variations immunity EN 61000-4-11 (Voltage Interruption/Dips)	Voltage dips: Residual voltage < 5% 0.5 Cycles Residual voltage < 70% 25 Cycles (50Hz), 30 Cycles (60Hz) Voltage interruptions: Residual voltage < 5% 250 Cycles (50Hz), 300 Cycles (60Hz)	AC Power Ports	B C C
Broadband impulse noise	0.15MHz to 0.5 MHz 107dBuV 0.5 MHz to 10 MHz 107dBuV to 36dBuV 10 MHz to 30 MHz 36dBuV to 30 dBuV	Analogue/digital data ports (Applicable only to CPE xDSL ports) (NOTE 1)	Α
disturbances,repetitive	0.70 ms 8.3 ms(for 60Hz) 10 ms(for 50Hz)	Analogue/digital data ports (Apply period based on the AC mains frequency) (NOTE 1)	А
Broadband impulse noise	0.15MHz to 30 MHz 110dBuV	Analogue/digital data ports (Applicable only to CPE xDSL ports) (NOTE 1)	В
disturbances,isolated	0.24 ms 10 ms(for 60Hz) 300 ms(for 50Hz)	Analogue/digital data ports (Apply all burst durations) (NOTE 1)	В

### Note.

- 1) Applicable only to ports which, according to the manufacturer's specification, may connect directly to outdoor cables.
- 2) Applicable only to ports which, according to the manufacturer's specification, support cable lengths greater than 3 m.
- 3) Where the coupling network for the 10/700 µs waveform affects the functioning of high speed data ports, the test shall be carried out using a 1,2/50 (8/20) µs waveform and appropriate coupling network.

Report No.: BTL-EMC-1-1907C057





### **5.2 GENERAL PERFORMANCE CRITERIA**

According to **EN 55035** standards, the general performance criteria as following:

Criterion A	performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion B	During the application of the disturbance, degradation of performance is allowed. However, nounintended change of actual operating state or stored data is allowed to persist after the test.  After the test, the equipment shall continue to operate as intended without operatorintervention; no degradation of performance or loss of function is allowed, below aperformance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.  If the minimum performance level (or the permissible performance loss), or recovery time, isnot specified by the manufacturer, then either of these may be derived from the productdescription and documentation, and by what the user may reasonably expect from the equipment if used as intended.
Criterion C	Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the

Report No.: BTL-EMC-1-1907C057 Page 28 0





### 5.3 ELECTROSTATIC DISCHARGE IMMUNITY TEST (ESD)

### **5.3.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-2
Discharge Impedance	330 ohm / 150 pF
Required Performance	В
Discharge Voltage	Air Discharge: ±2kV, ±4kV, ±8kV (Direct)
	Contact Discharge: ±2kV, ±4kV (Indirect)
Polarity	Positive & Negative
Number of Discharge	Air Discharge: min. 20 times at each test point
	Contact Discharge: min. 20 times at each test point
Discharge Mode	Single Discharge
Discharge Period	1 second minimum

#### **5.3.2 MEASUREMENT INSTRUMENTS**

Ite	m	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	1	ESD Generator	TESEQ AG	NSG 437	450	Sep. 28, 2019

Remark: "N/A" denotes no model name, no serial No. or no calibration specified. All calibration period of equipment list is one year.

### **5.3.3 TEST PROCEDURE**

The test generator necessary to perform direct and indirect application of discharges to the EUT in the following manner:

a. The test shall be performed with single discharges. On each pre-selected point at least 10single discharges (in the most sensitive polarity) shall be applied.

NOTE 1 The minimum number of discharges applied is depending on the EUT; for products with synchronized circuits the number of discharges should be larger. For the time interval bet ween successive single discharges an initial value of 1 s isrecommended. Longer intervals m av be necessary to determine whether a system failure hasoccurred.

NOTE 2 The points to which the discharges should be applied may be selected by means of an exploration carried out at a repetition rate of 20 discharges per second, or more. Vertical Coupling Plane (VCP):

The coupling plane, of dimensions 0.5m x 0.5m, is placed parallel to, and positioned at adistance 0.1m from, the EUT, with the Discharge Electrode touching the coupling plane.

The four faces of the EUT will be performed with electrostatic discharge.

Horizontal Coupling Plane (HCP):

The coupling plane is placed under to the EUT. The generator shall be positioned vertically at a distance of 0.1m from the EUT, with the Discharge Electrode touching the couplingplane. The four faces of the EUT will be performed with electrostatic discharge.

b. Air discharges at insulation surfaces of the EUT.

It was at least ten single discharges with positive and negative at the same selected point.

Report No.: BTL-EMC-1-1907C057

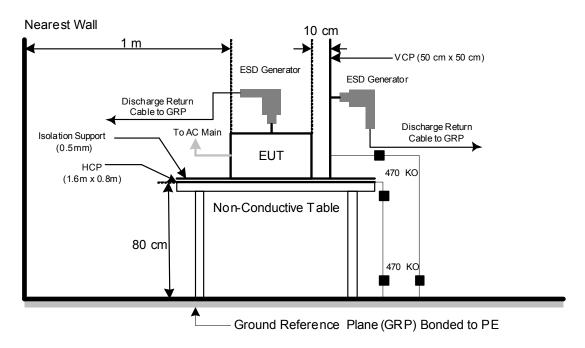




### **5.3.4 DEVIATION FROM TEST STANDARD**

No deviation

#### 5.3.5 TEST SETUP



#### Note:

### **TABLE-TOP EQUIPMENT**

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6m x 0.8m) was placed on the table and attached to the GRP by means of a cable with 940k total impedance. The equipment under test was installed in a representative system as described inIEC 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5mm thickness. A distance of1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

### FLOOR-STANDING EQUIPMENT

The equipment under test was installed in a representative system as described in IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25mm thick, and 2.5meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.

Report No.: BTL-EMC-1-1907C057

Page 30 of 56 Report Version: R00





### **5.3.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0302
Temperature	24°C	Relative Humidity	49%
Test Voltage	AC 230V/50Hz	Pressure	1017hPa
Test Mode	Mode 1		

Mode		Air Discharge						Contact Discharge						
	21	۲V	4	۲V	8	kV	- H	۲V	2k	:V	41	۲V	-k	XV
Location	Р	N	Р	N	Р	N	Р	N	Р	N	Р	N	Р	N
1	Α	Α	Α	Α	Α	Α	-	-	-	-	-	-	-	-
2	Α	Α	Α	Α	В	В	-	ı	-	-	ı	-	-	-
3	Α	Α	Α	Α	В	В	-	ı	-	-	ı	-	-	-
Criteria	В						- B				-	-		
Result	В					-	N/A					-		
Judgment			PA	SS				-		Ν	l/A		-	-

Mode	HCP Contact Discharge						VCP Contact Discharge						
	2k	۲V	41	kV	-ŀ	۲V	21	۲V	4	۲V	-k	XV	
Location	Р	N	Р	N	Р	N	Р	N	Р	N	Р	N	
1	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-	
2	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-	
3	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-	
4	Α	Α	Α	Α	-	-	Α	Α	Α	Α	-	-	
Criteria	В					-	В					-	
Result	Α				- A				-				
Judgment		PA	SS	•		-		PA	SS			_	

### Note:

1) Test condition:

Direct/Indirect(HCP/VCP) discharges: Minimum 20 times (Positive/Negative) at each point. Air discharges: Minimum 20 times (Positive/Negative) at each point.

- 2) Test location(s) in which discharge (Air and contact discharge) to be applied illustrated by photos shown in next page(s)
- 3) The Indirect (HCP/VCP) discharges description of test point as following:
- 1.left side; 2.right side; 3.front side; 4.rear side.
- 4) N/A denotes test is not applicable in device.

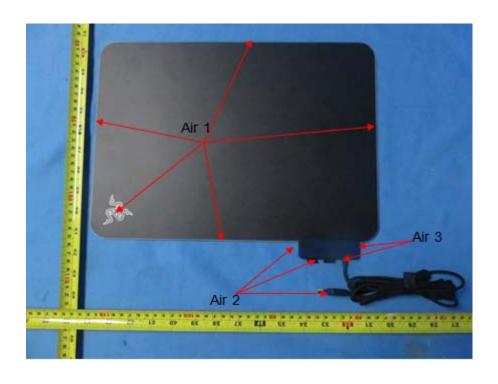
Report No.: BTL-EMC-1-1907C057

Page 31 of 56 Report Version: R00





## PHOTO(S) SHOWN THE LOCATION(S) OF ESD EVALUATED



Report No.: BTL-EMC-1-1907C057

Page 32 of 56 Report Version: R00





### 5.4 RADIATED, RADIO-FREQUENCY, ELECTROMAGNETIC FIELD IMMUNITY TEST (RS)

### **5.4.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-3
Required Performance	A
Frequency Range	80 MHz - 1000 MHz
	1800 MHz, 2600 MHz, 3500 MHz, 5000MHz
Field Strength	3 V/m(unmodulated, r.m.s)
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1% of fundamental
Polarity of Antenna	Horizontal and Vertical
Test Distance	3 m
Antenna Height	1.55 m
Dwell Time	at least 3 seconds

#### **5.4.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Antenna	ETS	3142C	47662	Mar. 09, 2020
2*	Amplifier	AR	50S1G4A	326720	Apr. 08, 2021
3	MXG Analog Signal Generator	Agilent	N5181A	MY49060710	Aug. 11, 2019
4*	Power amplifier	MILMEGA	AS1860-50	1064834	Mar. 10, 2022
5	Microwave LogPer. Antenna	TESEQ	STLP 9149	9149-277	Mar. 10, 2020
6*	Power amplifier	MILMEGA	80RF1000-250	1064833	Mar. 10, 2022
7	Measurement Software	TOYO	IM5/RS Ver 3.8.050	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.4.3 TEST PROCEDURE**

The EUT and support equipment, which are placed on a table that is 0.8 meter above ground and the testing was performed in a fully-anechoic chamber.

The testing distance from antenna to the EUT was 3 meters.

The other condition as following manner:

- a. The field strength level was 3V/m(unmodulated, r.m.s).
- b. The frequency range is swept from 80 MHz to 1000 MHz, 1800 MHz, 2600 MHz, 3500 MHz, 5000MHz with the signal 80%amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.
- d. The test was performed with the EUT exposed to both vertically and horizontallypolarized fields on each of the four sides.

#### 5.4.4 DEVIATION FROM TEST STANDARD

No deviation

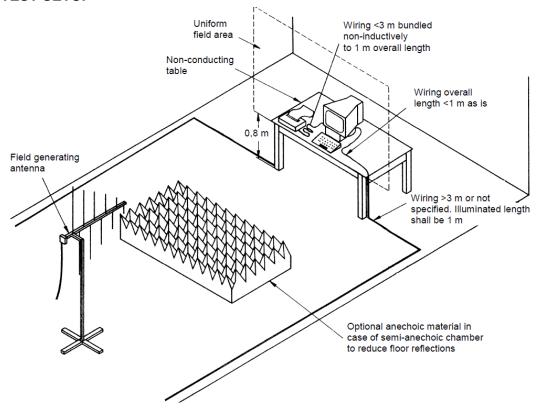
Report No.: BTL-EMC-1-1907C057 Page 33 of 56
Report Version: R00

<sup>&</sup>quot;\*" calibration period of equipment list is three year.





### 5.4.5 TEST SETUP



### NOTE:

### **TABLE-TOP EQUIPMENT**

The EUT installed in a representative system as described in EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in EN 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

Report No.: BTL-EMC-1-1907C057





### **5.4.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0302			
Temperature	24°C	Relative Humidity	54%			
Test Voltage	AC 230V/50Hz					
Test Mode	Mode 1					

Frequency Range	RF Field	R.F.	Azimuth	Criterion	Result	Judgment	
(MHz)	Position	Field Strength	Azimuun	Criterion	1 Count	oaagment	
		3V/m	0				
80 - 1000	H/V	(unmodulated, r.m.s)	90	Α	Α	PASS	
80 - 1000	117 V	AM Modulated	180	_ ^		FAGG	
		1000Hz, 80%	270				
		3V/m	0				
1800 (±1 %)	H/V	(unmodulated, r.m.s)	90	Α	Α	PASS	
1800 (±1 76)	117 V	AM Modulated	180			PASS	
		1000Hz, 80%	270				
	H/V	3V/m	0		A	PASS	
2600 (±1 %)		(unmodulated, r.m.s)	90	Α			
2000 (±1 70)		AM Modulated	180				
		1000Hz, 80%	270				
		3V/m	0				
3500 (±1 %)	H/V	(unmodulated, r.m.s)	90	Α	Α	PASS	
3300 (±1 70)	11/ V	AM Modulated	180		A	PASS	
		1000Hz, 80%	270				
		3V/m	0				
5000 (±1 %)	H/V	(unmodulated, r.m.s)	90	Α	Α	PASS	
3000 (±1 /0)	H/V	AM Modulated	180		A	PASS	
		1000Hz, 80%	270				

Note:

1) N/A - denotes test is not applicable in device.

Report No.: BTL-EMC-1-1907C057

Page 35 of 56 Report Version: R00





### 5.5 ELECTRICAL FAST TRANSIENT/BURST IMMUNITY TEST (EFT/BURST)

### 5.5.1 TEST SPECIFICATION

Basic Standard	EN 61000-4-4
Required Performance	В
Test Voltage	AC mains power ports: ±1 kV
Polarity	Positive & Negative
Impulse Frequency	5 kHz: except for xDSL port
-	100 kHz: only for single lines of xDSL port.
Impulse Wave shape	5/50 ns
Burst Duration	15 ms
Burst Period	300 ms
Test Duration	Not less than 1 min.

### **5.5.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 11, 2019

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

### **5.5.3 TEST PROCEDURE**

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. Both positive and negative polarity discharges were applied.
- b. The duration time of each test sequential was 1 minute

### 5.5.4 DEVIATION FROM TEST STANDARD

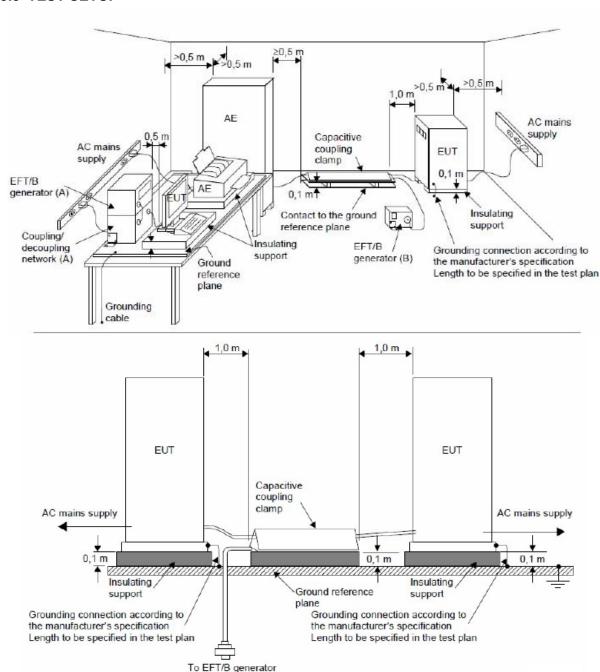
No deviation

Report No.: BTL-EMC-1-1907C057 Page 3





#### 5.5.5 TEST SETUP



#### Note:

#### **TABLE-TOP EQUIPMENT**

The configuration consisted of a wooden table (0.8m high) standing on the Ground Reference Plane and should be located 0.1 m+/- 0.01m above the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system. A minimum distance of 0.5m was provided between the EUT and the walls of the laboratory or any other metallic structure.

#### FLOOR-STANDING EQUIPMENT

The EUT installed in a representative system as described in IEC 61000-4-4 and its cables were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25mm thick and 2.5m square) connected to the protective grounding system.





# 5.5.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0302		
Temperature	25°C	Relative Humidity	51%		
Test Voltage	AC 230V/50Hz				
Test Mode	Mode 1				

EUT Ports	EUT Ports Tested		Repetition Frequency	Test Level 1kV	Criterion	Result	Judgment
	Line (L)	+	5 kHz	А	В	А	PASS
	LIIIe (L)	-	5 kHz	Α	Б		FASS
	Noutral (NI)	+	5 kHz	Α	В	А	PASS
	Neutral (N)	-	5 kHz	Α	Ь	A	PASS
	Ground (PE)	+	5 kHz	Α	В	Α	PASS
		-	5 kHz	Α			
AC mains power	L+N	+	5 kHz	Α	В	Α	PASS
ports		-	5 kHz	Α			
	LIDE	+	5 kHz	Α		۸	PASS
	L+PE	-	5 kHz	Α	В	Α	
	N+PE	+	5 kHz	Α	В	۸	PASS
	NTPE	-	5 kHz	Α	Б	Α	PASS
	LANDE	+	5 kHz	Α	Б	Α	DAGG
	L+N+PE	-	5 kHz	Α	В		PASS

Note:

1) N/A - denotes test is not applicable in device.

Report No.: BTL-EMC-1-1907C057

Page 38 of 56 Report Version: R00





# **5.6 SURGE IMMUNITY TEST**

# **5.6.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-5
Required Performance	B(AC mains power ports)
	B/C(Analogue/digital data ports)
Wave-Shape	Combination Wave for power lines
	1.2/50 us Open Circuit Voltage
	8 /20 us Short Circuit Current
Test Voltage	AC mains power ports: ±0.5 kV, ±1 kV, ±2 kV
Surge Input/Output	L – N, L – PE, N – PE
Generator Source	2 Ω of the low-voltage power supply network.
Impedance	12 $\Omega$ (10 $\Omega$ +2 $\Omega$ ) of the low-voltage power supply
	network and ground.
Phase Angle and Polarity:	Five positive pulses line-to-neutral at 90° phase
	Five negative pulses line-to-neutral at 270° phase
	Five positive pulses line-to-earth at 90° phase
	Five negative pulses line-to-earth at 270° phase
	Five negative pulses neutral-to-earth at 90° phase
	Five positive pulses neutral-to-earth at 270° phase
Pulse Repetition Rate	1 time / min. (maximum)
Number of Tests	5 positive and 5 negative at selected points

# **5.6.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 11, 2019

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.





#### **5.6.3 TEST PROCEDURE**

a. For EUT power supply:

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines, and to provide sufficient decoupling impedance to the surge wave. The power cord between the EUT and the coupling/decoupling networks shall be 2meters in length (or shorter).

- b. For test applied to unshielded unsymmetrically operated interconnection lines of EUT:

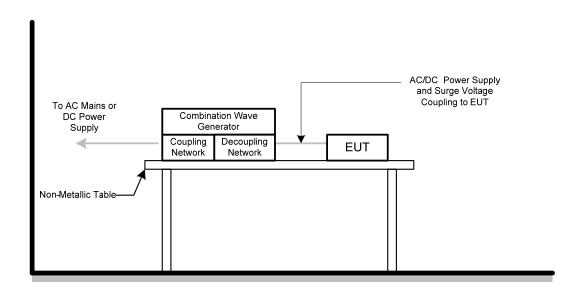
  The surge is applied to the lines via the capacitive coupling. The coupling /decoupling networks shall not influence the specified functional conditions of the EUT. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).
- c. For test applied to unshielded symmetrically operated interconnection /telecommunication lines of EUT:

The surge is applied to the lines via gas arrestors coupling. Test levels below the ignition point of the coupling arrestor cannot be specified. The interconnection line between the EUT and the coupling/decoupling networks shall be 2 meters in length (or shorter).

#### **5.6.4 DEVIATION FROM TEST STANDARD**

No deviation

#### 5.6.5 TEST SETUP







# 5.6.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0302			
Temperature	25°C	Relative Humidity	50%			
Test Voltage	AC 230V/50Hz	AC 230V/50Hz				
Test Mode	Mode 1					

\\/o	wo Form		1.2/50(8/20)Tr/Thµs							
Wave Form EUT Ports Tested Polarity P		Dhaca	Voltage		Criterion	Result	Judgment			
LOTE	EUT Ports Tested Pola		- clarity   Friase		1kV	kV	kV			
۸.	I NI	+	90°	Α	Α	1	1	D	۸	DACC
AC L-N		-	270°	Α	Α	-	1	Б	A	PASS

\//o	u Corm		1.2/50(8/20)Tr/Thµs							
Wave Form EUT Ports Tested		Polarity	Dhaca	Voltage		Criterion	Result	Judgment		
LOTI	Oris resieu	Folanty	Filase	0.5kV	1kV	2kV	kV			
	L – PE	+	90°	Α	Α	Α	-	В	Α	PASS
AC		-	270°	Α	Α	Α	-	Ь	Α	PASS
AC	N – PE	-	90°	Α	Α	Α	-	В	Α	PASS
N-PE	+	270°	Α	Α	Α	-	В	A	PASS	

Note:

1) N/A - denotes test is not applicable in device.

Report No.: BTL-EMC-1-1907C057

Page 41 of 56 Report Version: R00





# 5.7 IMMUNITY TO CONDUCTED DISTURBANCES, INDUCED BY RADIO-FREQUENCY FIELDS TEST (CS)

#### **5.7.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-6
Required Performance	A
Frequency Range&Field Strength	0.15 MHz - 10 MHz - 3V (unmodulated, r.m.s.) 10 MHz - 30 MHz - 3V to 1V (unmodulated, r.m.s.) 30 MHz - 80 MHz - 1V (unmodulated, r.m.s.)
Modulation	1 kHz Sine Wave, 80%, AM Modulation
Frequency Step	1% of fundamental
Dwell Time	at least 3 seconds

#### **5.7.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	TEST SYSTEM FOR CONDUCTED AND RADIATED IMMUNITY	TESEQ	NSG 4070B	37513	Aug. 11, 2019
2	Power CDN	FCC	FCC-801-M 2/M3-16A	100270	Mar. 10, 2020
3	Measurement Software	Farad	EZ-CS (V2.0.1.3)	N/A	N/A

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

#### **5.7.3 TEST PROCEDURE**

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The field strength level was 3 V (unmodulated, r.m.s.)
- b. The frequency range is swept from 150 kHz to 80 MHz, with the signal 80%amplitude modulated with a 1 kHz sine wave. The rate of sweep did not exceed 1.5x 10-3 decade/s. Where the frequency range is swept incrementally, the step size was 1% of fundamental.
- c. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond.

Report No.: BTL-EMC-1-1907C057 Page

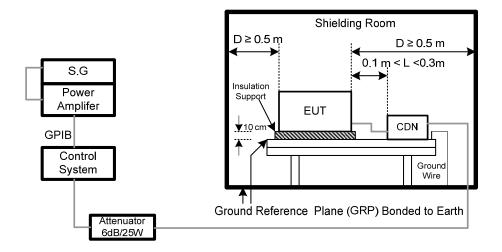




#### 5.7.4 DEVIATION FROM TEST STANDARD

No deviation

#### 5.7.5 TEST SETUP



#### NOTE:

#### FLOOR-STANDING EQUIPMENT

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

Report No.: BTL-EMC-1-1907C057

Page 43 of 56 Report Version: R00





# **5.7.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0302		
Temperature	25°C	Relative Humidity	56%		
Test Voltage	AC 230V/50Hz				
Test Mode	Mode 1				

Test Ports (Mode)	Freq.Range (MHz)	Field Strength	Criteria	Results	Judgment
AC mains power ports	0.15 - 10 10 - 30	3V (unmodulated, r.m.s.) 3V to 1V (unmodulated, r.m.s.)	А	А	PASS
	30 - 80	1V (unmodulated, r.m.s.)			

Note:

1). N/A - denotes test is not applicable in device.

Report No.: BTL-EMC-1-1907C057

Page 44 of 56 Report Version: R00





# 5.8 POWER FREQUENCY MAGNETIC FIELD IMMUNITY TEST (PFMF)

#### **5.8.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-8
Required Performance	A
Frequency Range	50/60 Hz
Field Strength	1 A/m
Observation Time	1 minute
Inductance Coil	Rectangular type, 1mx1m

#### **5.8.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Magnetic Field test Generator	FCC	F-1000-4-8- G-125A	4032	Mar. 10, 2020
2	Magnetic Field immunity loop	Thermo KeyTek	F-1000-4-8/ 9/10-L-1M	4024	Mar. 10, 2020

Remark: "N/A" denotes no model name, no serial No. or no calibration specified. All calibration period of equipment list is one year.

#### **5.8.3 TEST PROCEDURE**

The EUT and support equipment, are placed on a table that is 0.8 meter above a metal ground plane measured 1m\*1m min. and 0.65mm thick min.

The other condition as following manner:

- a. The equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- b. The cables supplied or recommended by the equipment manufacturer shall be used. 1 meter of all cables used shall be exposed to the magnetic field.

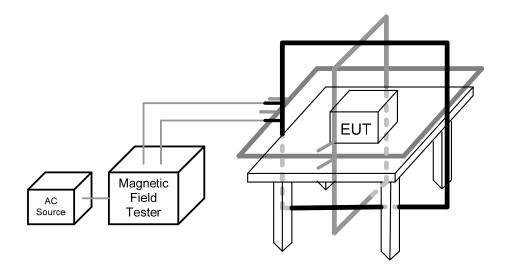
#### 5.8.4 DEVIATION FROM TEST STANDARD

No deviation





#### 5.8.5 TEST SETUP



#### Note:

#### TABLE-TOP EQUIPMENT

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

#### FLOOR-STANDING EQUIPMENT

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 percent of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

Report No.: BTL-EMC-1-1907C057

Page 46 of 56 Report Version: R00





# **5.8.6 TEST RESULTS**

EUT	Gaming Mouse Mat	Model Name	RZ02-0302		
Temperature	25°C	Relative Humidity	51%		
Test Voltage	AC 230V/50Hz				
Test Mode	Mode 1				

# 50Hz

Test Mode	Test Level	Antenna aspect	Duration (s)	Criteria	Results	Judgment
Enclosure	1 A/m	Х	60	Α	Α	PASS
Enclosure	1 A/m	Y	60	Α	Α	PASS
Enclosure	1 A/m	Z	60	Α	Α	PASS

# 60Hz

<u> </u>							
Test	Mode	Test Level	Antenna aspect	Duration (s)	Criteria	Results	Judgment
Enclo	osure	1 A/m	Х	60	А	А	PASS
Enclo	osure	1 A/m	Y	60	А	Α	PASS
Enclo	osure	1 A/m	Z	60	Α	Α	PASS

Note:

1). N/A - denotes test is not applicable in device.

Report No.: BTL-EMC-1-1907C057

Page 47 of 56 Report Version: R00





# 5.9 VOLTAGE DIPS, SHORT INTERRUPTIONS AND VOLTAGE VARIATIONS IMMUNITY TEST

#### **5.9.1 TEST SPECIFICATION**

Basic Standard	EN 61000-4-11
Required Performance	Voltage dips:
	(B) Residual voltage<5% 0.5 Cycles
	(C) Residual voltage70% 25 Cycles (50Hz),30 Cycles (60Hz)
	Voltage interruptions:
	(C) Residual voltage<5% 250 Cycles (50Hz), 300 Cycles (60Hz)
Test Duration Time	Minimum three test events in sequence
Interval between Event	Minimum ten seconds
Phase Angle	0°/180°
Test Cycle	3 times

#### **5.9.2 MEASUREMENT INSTRUMENTS**

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	THE MODULAR SOLUTION FOR 6 KV APPLICATIONS	Teseq	NSG 3060	1423	Aug. 11, 2019

Remark: "N/A" denotes no model name, no serial No. or no calibration specified.

All calibration period of equipment list is one year.

# **5.9.3 TEST PROCEDURE**

The EUT shall be tested for each selected combination of test levels and duration with a sequence of three dips/interruptions with intervals of 10 s minimum (between each test event). Each representative mode of operation shall be tested. Abrupt changes in supply voltage shall occur at zero crossings of the voltage waveform.

#### 5.9.4 DEVIATION FROM TEST STANDARD

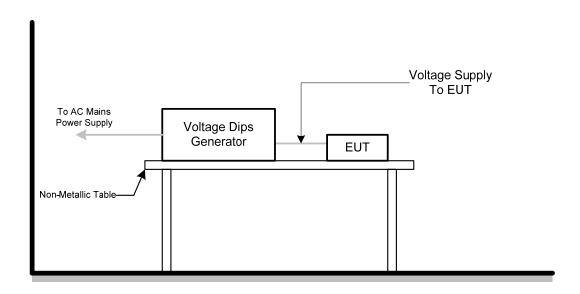
No deviation

Report No.: BTL-EMC-1-1907C057 Page 48





# 5.9.5 TEST SETUP



Report No.: BTL-EMC-1-1907C057

Page 49 of 56 Report Version: R00





# 5.9.6 TEST RESULTS

EUT	Gaming Mouse Mat	Model Name	RZ02-0302		
Temperature	25°C	Relative Humidity	50%		
Test Voltage	AC 100V/50Hz, AC 230V/50Hz, AC 240V/50Hz				
Test Mode	Mode 1				

AC 100V/50Hz							
Item	Residual Voltage	Cycles	Criteria	Results	Judgment		
Voltage dips	<5%	0.5	В	А	PASS		
Voltage dips	70%	25	С	А	PASS		
Voltage Interruption	<5%	250	С	С	PASS		

AC 230V/50Hz							
Item	Residual Voltage	Cycles	Criteria	Results	Judgment		
Voltage dips	<5%	0.5	В	А	PASS		
Voltage dips	70%	25	С	Α	PASS		
Voltage Interruption	<5%	250	С	С	PASS		

AC 240V/50Hz							
Item	Residual Voltage	Cycles	Criteria	Results	Judgment		
Voltage dips	<5%	0.5	В	Α	PASS		
Voltage dips	70%	25	С	Α	PASS		
Voltage Interruption	<5%	250	С	С	PASS		

# Note:

1). N/A - denotes test is not applicable in device.

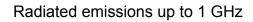
Report No.: BTL-EMC-1-1907C057

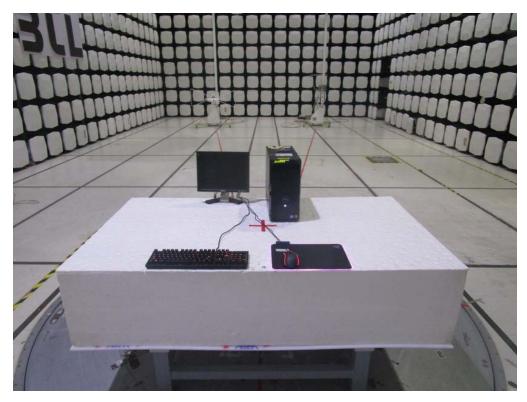
Page 50 of 56 Report Version: R00

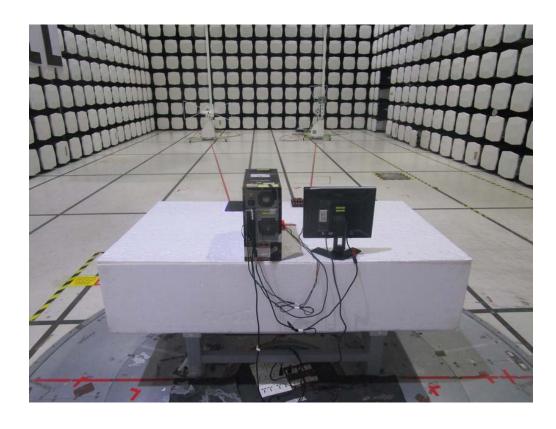




# **6.EUT TEST PHOTO**







Report No.: BTL-EMC-1-1907C057

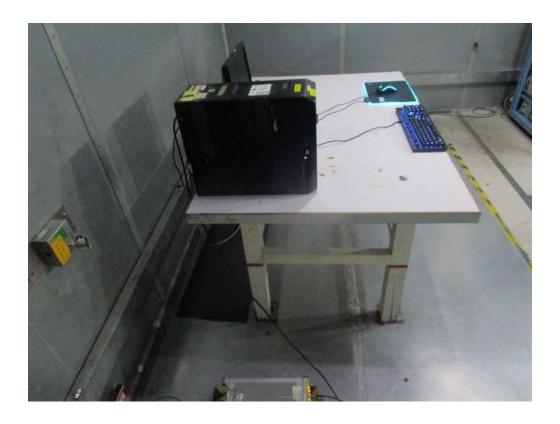
Page 51 of 56 Report Version: R00





# Conducted emissions AC mains power port





Report No.: BTL-EMC-1-1907C057

Page 52 of 56 Report Version: R00





# Electrostatic discharge immunity



Radiated, radio-frequency, electromagnetic field immunity – Up to 1GHz



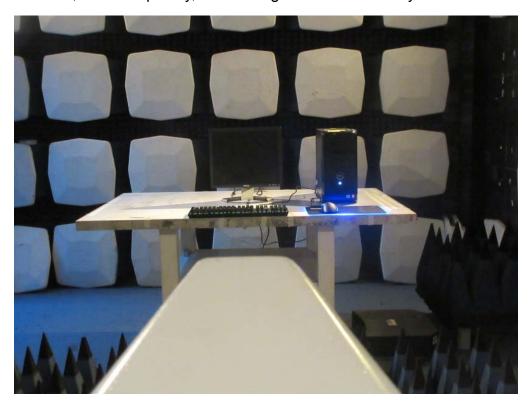
Report No.: BTL-EMC-1-1907C057

Page 53 of 56 Report Version: R00





Radiated, radio-frequency, electromagnetic field immunity – Above 1GHz



Electrical fast transient/burst immunity



Report No.: BTL-EMC-1-1907C057

Page 54 of 56 Report Version: R00





# Surge immunity



Immunity to conducted disturbances, induced by radio-frequency fields



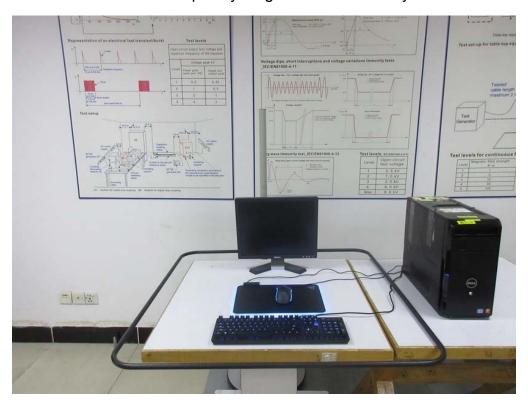
Report No.: BTL-EMC-1-1907C057

Page 55 of 56 Report Version: R00





# Power frequency magnetic field immunity



Voltage dips, short interruptions and voltage variations immunity



**End of Test Report** 

Report No.: BTL-EMC-1-1907C057

Page 56 of 56 Report Version: R00